## NCERT SOLUTIONS SEMICONDUCTOR ELECTRONICS

- In an n-type silicon, which of the following statement is true?
  - (a) Electrons are majority carriers and trivalent atoms are the dopants.
  - (b) Electrons are minority carriers and pentavalent atoms are the dopants.
  - (c) Holes are minority carriers and pentavalent atoms are the dopants.
  - (d) Holes are majority carriers and trivalent atoms are the dopants.
- Sol. (c). 'Holes are minority carriers and trivalent atoms are the dopants in n-type semiconductors.
- 14.2 Which of the statements given in Q. 14.1 is true for p-type semiconductos.
- Sol. (d). Holes are majority carriers and trivalent atoms are the dopants in p-type semiconductors.
- 14.3 Carbon, silicon and germanium have four valence electrons each. These are characterised by valence and conduction bands separated by energy band gap respectively equal to  $(E_{\sigma})_{C_i}$ ,  $(E_{\sigma})_{S_i}$  and  $(E_{\sigma})_{G_c}$ . Which of the following statements is true?
  - (a)  $(E_g)_{Si} < (E_g)_{Ge} < (E_g)_C$
- (b)  $(E_g)_C < (E_g)_{Ge} > (E_g)_{Si}$ (d)  $(E_g)_C = (E_g)_{Si} = (E_g)_{Ge}$
- $(c) (E_g)_C > (E_g)_{Si} > (E_g)_{Ge}$
- $\label{eq:condition} (c) \; (E_g)_C \; > \; (E_g)_{Si} \; \; > (E_g)_{Ge} \; .$

Energy band gap is maximum in carbon and least in germanium among the given elements.

- 14.4 In an unbiased p-n junction, holes diffuse from the p-region to n-region because-
  - (a) free electrons in the n-region attract them.
  - (b) they move across the junction by the potential difference.
  - (c) hole concentration in p-region is more as compared to n-region.
  - (d) All the above.
- (c). Hole concentration in p-region is more as compared to n-region because hole diffusion takes place from higher concentration to lower concentration.
- 14.5 When a forward bias is applied to a p-n junction, it
  - (a) raises the potential barrier.
  - (b) reduces the majority carrier current to zero.
  - (c) lowers the potential barrier.
  - (d) None of the above.
- (c). Lowers the potential barrier by canceling the depletion layer. Sol.
- For transistor action, which of the following statements are correct:
  - (a) Base, emitter and collector regions should have similar size and doping concentrations.
  - (b) The base region must be very thin and lightly doped.
  - (c) The emitter junction is forward biased and collector junction is reverse biased.
  - (d) Both the emitter junction as well as the collector junction are forward biased.
- (b) and (c). The base region must be very thin, lightly doped and the emitter junction is forward biased whereas collector junction is reverse biased to avoid unnecessary diffusion of charge carrier in the base and also for proper amplification.
- 14.7 For a transistor amplifier, the voltage gain
  - (a) remains constant for all frequencies.
  - (b) is high at high and low frequencies and constant in the middle frequency range.
  - (c) is low at high and low frequencies and constant at mid frequencies.
  - (d) None of the above.

- Sol. (c). Is low at high and low frequencies and constant at mid frequencies as per frequency response of a transistor.
- In half-wave rectification, what is the output frequency if the input frequency is 50 Hz. What is the 14.8 output frequency of a full-wave rectifier for the same input frequency.
- Sol. A half wave rectifier rectifies only one half cycle of input A.C.
  - :. Frequency of the output A.C. = frequency of input A.C. = 50 Hz
  - A full wave rectifier rectifies both halve cycles of the A.C. input
  - $\therefore$  Frequency of output A.C. = 2 × frequency of input of A.C. = 2 × 50 = 100 Hz.
- For a CE-transistor amplifier, the audio signal voltage across the collected resistance of  $2 \text{ k}\Omega$  is 2 V. Suppose the current amplification factor of the transistor is 100, find the input signal voltage and base current, if the base resistance is  $1k\Omega$ .
- Here  $R_0 = 2K\Omega = 2000 \Omega$ ;  $\alpha = 100$ 
  - :. Voltage amplification factor

$$A_v = \frac{V_0}{V_i} = \alpha \frac{R_0}{R_i}$$

$$\therefore V_i = \frac{V_0.R_i}{\alpha R_0} = \frac{2 \times 1000}{100 \times 2000} = 0.01 \text{ V}$$

Also 
$$I_b = \frac{V_i}{R_i} = \frac{0.01}{1000} = 1 \times 10^{-5} \text{ A} = 1 \times 10^{-5} \times 10^6 \text{ } \mu\text{A} = 10 \text{ } \mu\text{A}$$

- 14.10 Two amplifiers are connected one after the other in series (cascaded). The first amplifier has a voltage gain of 10 and the second has a voltage gain of 20. If the input signal is 0.01 volt, calculate the output ac signal.
- Here  $A_{v_1} = 10$  and  $A_{v_2} = 20$ Sol.
  - ... Net voltage again gain  $A_v = x = 10 \times 20 = 200$ Now using  $A_v = \frac{V_0}{V_i}$ ...  $V_0 = A_v$ .  $V_i = 0.01 \times 200 = 2 \text{ V}$

Now using 
$$A_v = \frac{V_0}{V_0}$$

$$V_0 = A_v$$
.  $V_i = 0.01 \times 200 = 2 \text{ V}$ 

- 14.11 A p-n photodiode is fabricated from a semiconductor with band gap of 2.8eV. Can it detect a wavelength of 6000 nm?
- Here  $E_g = 2.8 \text{ eV} = 2.8 \times 1.6 \times 10^{-19} = 4.48 \times 10^{-19} \text{ J}$ ;

$$\lambda = 6000 \text{ nm} = 6000 \times 10^{-9} \text{ m}$$

:. energy, 
$$E = \frac{hc}{\lambda} = \frac{6.62 \times 10^{-34} \times 3 \times 10^8}{6000 \times 10^{-9}} = 3.31 \times 10^{-20} \text{ J}$$

Since the energy of the light photon is more than the band gap energy of p-n diode, it can not be detected.

- **14.12** The number of silicon atoms per m<sup>3</sup> is  $5 \times 10^{28}$ . This is doped simultaneously with  $5 \times 10^{22}$  atoms per m<sup>3</sup> of Arsenic and  $5 \times 10^{20}$  per m<sup>3</sup> atoms of Indium. Calculate the number of electrons and holes. Given that  $n_i = 1.5 \times 10^{16}$  m<sup>-3</sup>. Is the material n-type or p-type?
- **Sol.**  $n_e = 5 \times 10^{22} 5 \times 10^{20} = (5 0.05)10^{22} = 4.95 \times 10^{22} \text{ m}^{-3}.$

$$n_h = \frac{n_i^2}{n_e} = \frac{(1.5 \times 10^{16})^2}{4.95 \times 10^{22}} = 4.55 \times 10^9 \text{ m}^{-3}.$$

Since  $n_e \gg n_h$ , the semiconductor is an n-type semiconductor.

14.13 In an intrinsic semiconductor the energy gap E<sub>g</sub> is 1.2eV. Its hole mobility is much smaller than electron mobility and independent of temperature. What is the ratio between conductivity at 600K and that at 300K? Assume that the temperature dependence of intrinsic carrier concentration n<sub>i</sub> is

given by : 
$$n_i = n_0 \exp\left(-\frac{E_g}{2k_BT}\right)$$
, where  $n_0$  is a constant.

$$\mathbf{Sol.} \qquad \frac{K_1}{K_2} = \frac{n_1}{n_2} = \frac{e^{-\frac{E_g}{2k_BT_1}}}{e^{-\frac{E_g}{2k_BT_2}}} = e^{\frac{E_g}{2K_B} \left[\frac{1}{T_2} - \frac{1}{T_1}\right]} = e^{\frac{1.2}{2 \times 8.6 \times 10^{-5}} \left[\frac{1}{300} - \frac{1}{600}\right]} = e^{\frac{1.2}{2 \times 8.6 \times 3 \times 10^{-3}} \left[\frac{1}{1} - \frac{1}{2}\right]} = \frac{1}{e^{8.6 \times 10^{-2}}}$$

$$=e^{11.6279}=\ 1.12\times 10^5=1\times 10^5\ A.$$

**14.14** In a p-n junction diode, the current I can be expressed as  $I = I_0 \exp\left(\frac{eV}{2k_BT} - 1\right)$ ; where  $I_0$  is called

the reverse saturation current, V is the voltage across the diode and is positive for forward bias and negative for reverse bias, and I is the current through the diode, kB is the Boltzmann constant  $(8.6 \times 10^{-5} \text{ eV/K})$  and T is the absolute temperature. If for a given diode  $I_0 = 5 \times 10^{-12} \text{ A}$  and T = 300 K, then

- (a) What will be the forward current at a forward voltage of 0.6 V?
- (b) What will be the increase in the current if the voltage across the diode is increased to 0.7 V?
- (c) What is the dynamic resistance?
- (d) What will be the current if reverse bias voltage changes from 1 V to 2 V?
- **Sol.** Statement of the given question is incorrect. The relation should be

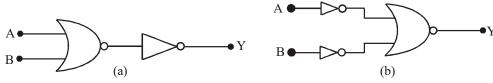
(a) 
$$I = I_0 \left( e^{\frac{eV}{2K_BT} - 1} \right) = I_0 \left( e^{\frac{0.6}{2 \times 8.6 \times 10^{-5} \times 300}} \right) = 5 \times 10^{-12} \left[ 1.259 \times 10^{10} - 1 \right] = 0.063 \text{ A}$$
  
(b)  $I = I_0 \left( e^{\frac{eV}{2K_BT} - 1} \right) = 5 \times 10^{-12} \left[ 6.07 \times 10^{11} - 1 \right] = 3.035 \text{ A}$ 

(b) 
$$I = I_0 \left( e^{\frac{eV}{2K_BT} - 1} \right) = 5 \times 10^{-12} \left[ 6.07 \times 10^{11} - 1 \right] = 3.035 \text{ A}$$

:. Increase in current 
$$\Delta I = (3.035 - 0.063) = 2.972 \text{ A}$$

(c) 
$$R_d = \frac{\Delta V}{\Delta I} = \frac{0.1V}{2.972V} = 0.0336 \Omega$$

- (d) For both the voltages, the current I will be almost equal to I<sub>0</sub>, showing almost infinite dynamic resistance in the reverse bias.
- 14.15 You are given the two circuits as shown in figure. Show that circuit (a) acts as OR gate while the circuit (b) acts as AND gate.



**Sol.** In fig. (a), 
$$y_1 = \overline{A + B}$$
 and  $Y = \overline{y_1}$   

$$\therefore Y = \overline{\overline{A + B}} = A + B$$
 (Boolean algebra)

in fig. (b), 
$$Y = \overline{y_1 + y_2} = \overline{y_1}.\overline{y_2}$$
 (Using de Morgan theorem)

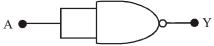
But 
$$y_1 = \overline{A}$$
 and  $y_2 = \overline{B}$ 

$$\therefore$$
 Y =  $\overline{y_1.y_2}$  =  $\overline{A \cdot B}$  = A. B which is an AND operation.

Clearly fig. (b) represents an AND gate.

**Alt.:** Prepare truth table.

14.16 Write the truth table for a NAND gate connected as given in figure.



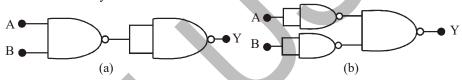
Sol. The NAND gate shown in the truth table has only one input. Therefore, the truth table is

	A	A	$y = \overline{A.A}$
	0	0	1
ĺ	1	1	0

Since  $Y = \overline{A}$  in this case, the circuit is actually a NOT gate with the truth table

	A	Y
	0	1
ĺ	1	0

14.17 You are given two circuits as shown in Fig., which consist of NAND gates. Identify the logic operation carried out by the two circuits.



**Sol.** In the fig. (a)  $Y = \overline{y_1.y_1} = \overline{y_1}$ 

But 
$$y_1 = \overline{A.B}$$

$$Y = \overline{A.B} = A.B$$

which is an AND operation.

Therefore the fig. (a) represents an AND gate.

In fig. (b), 
$$Y = \overline{y_1.y_2}$$

But 
$$v_1 =$$

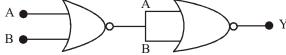
$$y_1 = \overline{A.A} = \overline{A}$$

$$= BBB = B$$

and 
$$y_2 = \overline{B.B} = \overline{B}$$
  
 $\therefore Y = \overline{y_1.y_2} = \overline{\overline{A.\overline{B}}} = \overline{\overline{A}} + \overline{B}$  (de Morgan theorem)

= A + B which is an OR operation.

- :. Fig. (b) represents an OR gate.
- 14.18 Write the truth table for circuit given in figure below consisting of NOR gates and identify the logic operation (OR, AND, NOT) which this circuit is performing.



**Sol.** Let  $y_1$  be the out which appears at the first operation of NOR gate.

Then 
$$y_1 = \overline{A + B}$$
 .....(1)

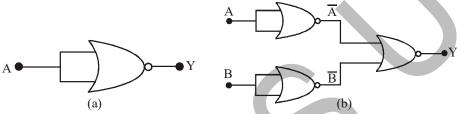
This output is fed into an other NOR gate so that  $Y = \overline{y_1 + y_1}$ 

Now using Boolean Algebra,  $y_1 + y_1 = y_1$ 

- $\therefore Y = \overline{y}_1 = \overline{A + B}$  (using eqn. (1))
  - = A + B which is an OR operation.
- :. The circuit is an OR gate and its truth table is

A	В	Y
0	0	0
1	0	1
0	1	1
1	1	1

**14.19** Write the truth table for the circuits given in figure consisting of NOR gates only. Identify the logic operations (OR, AND, NOT) performed by the two circuits.



- **Sol.** In fig. (a)  $Y = \overline{A + A}$ 
  - :. Using Boolean algebra (De-Morgan theorem)

$$Y = \overline{A.A} = \overline{A}$$

$$(: \overline{A+B} = \overline{A} \cdot \overline{B})$$

:. This is a NOT operation. Therefore, fig. (i) represents a NOT gate.

In fig. (b) 
$$Y = \overline{\overline{A} + \overline{B}} = \overline{\overline{A}} \cdot \overline{\overline{B}}$$

- = A . B which is an AND operation.
- : the fig. (ii) represents an AND gate.